



N-Channel 30-V (D-S) MOSFET

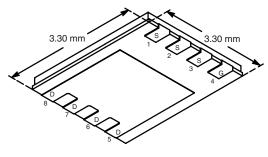
PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^{a, g}	Q _g (Typ.)			
30	0.006 at V _{GS} = 10 V	35	12 nC			
	0.008 at V _{GS} = 4.5 V	35	12110			

FEATURES

- Halogen-free
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

RoHS COMPLIANT

PowerPAK® 1212-8

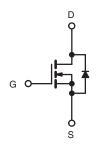


Bottom View

Ordering Information: SiS402DN-T1-GE3 (Lead (Pb)-free and Halogen-free)

APPLICATIONS

- DC/DC Converter
 - Notebook
 - POL



N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	30		
Gate-Source Voltage		V _{GS}	± 20	V	
	T _C = 25 °C		35 ^{a, g}		
Continuous Drain Current (T. 150 °C)	T _C = 70 °C		35 ^g		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	19 ^{b, c}	•	
	T _A = 70 °C		15 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	70		
Avalanche Current	L = 0.1 mH	I _{AS}	35		
Avalanche Energy	L = U.1 MID	E _{AS}	61	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	1	43	۸	
	T _A = 25 °C	I _S	3.2 ^{b, c}	A	
	T _C = 25 °C		5.2		
Maximum Power Dissipation	T _C = 70 °C	ь	33	w	
	T _A = 25 °C	P _D	3.8 ^{b, c}		
	T _A = 70 °C		2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}		Ĭ	260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol Typical		Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R_{thJA}	24	33	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	1.9	2.4	O/ VV	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK 1212 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 81 °C/W.
- g. Package limited.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	-				L	1	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		24		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1	μΑ	
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	50			Α	
D : 0	R _{DS(on)}	V _{GS} = 10 V, I _D = 19 A		0.0048	0.006	Ω	
Drain-Source On-State Resistance ^a		V _{GS} = 4.5 V, I _D = 16.6 A		0.0064	0.008		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 19 A		82		S	
Dynamic ^b				•			
Input Capacitance	C _{iss}			1700		pF	
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		350			
Reverse Transfer Capacitance	C _{rss}			140			
	Q _g	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 19 \text{ A}$		28	42	nC	
Total Gate Charge				12	21		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 19 \text{ A}$		5.4			
Gate-Drain Charge	Q_{gd}			4.6			
Gate Resistance	R_g	f = 1 MHz		1.2	2.4	Ω	
Turn-On Delay Time	t _{d(on)}			25	40	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω		20	30		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		25	40		
Fall Time	t _f			15	25		
Turn-On Delay Time	t _{d(on)}			12	20		
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω		10	15		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω		25	40		
Fall Time	t _f			10	15		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			30	A	
Pulse Diode Forward Current	I _{SM}				70	_^	
Body Diode Voltage	V_{SD}	I _S = 10 A, V _{GS} = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			25	50	ns	
Body Diode Reverse Recovery Charge	Q_{rr}	I _F = 10 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		17	35	nC	
Reverse Recovery Fall Time	t _a	i _F = 10 A, αί/αι = 100 A/μs, 1 _J = 25 °C		13		20	
Reverse Recovery Rise Time				12		ns	

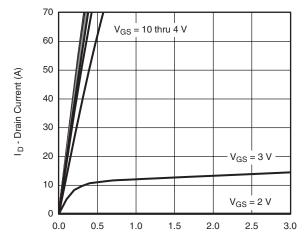
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

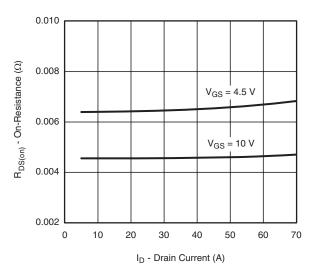


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

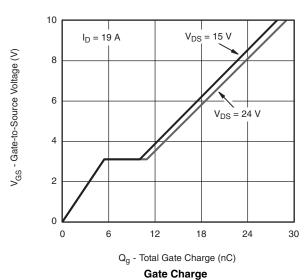


V_{DS} - Drain-to-Source Voltage (V)

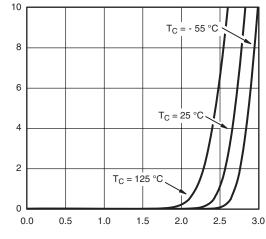
Output Characteristics



On-Resistance vs. Drain Current and Gate Voltage

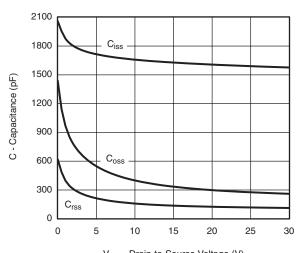


I_D - Drain Current (A)



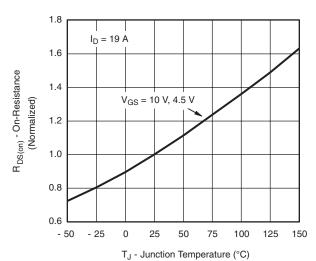
V_{GS} - Gate-to-Source Voltage (V)





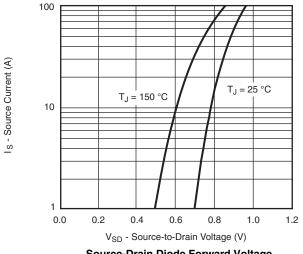
V_{DS} - Drain-to-Source Voltage (V)

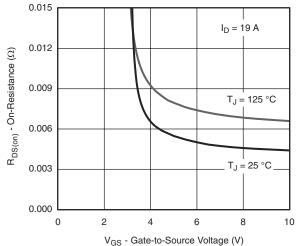
Capacitance



On-Resistance vs. Junction Temperature

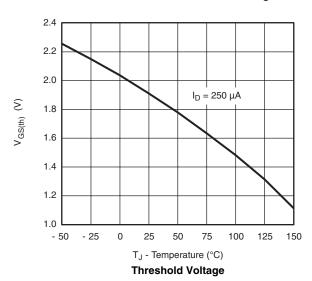
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

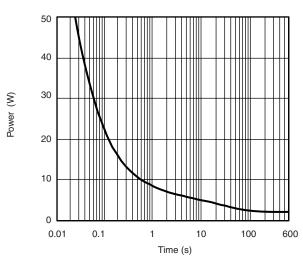




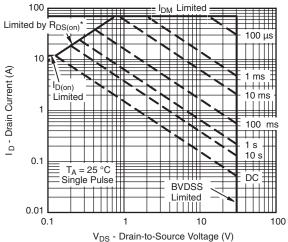
Source-Drain Diode Forward Voltage







Single Pulse Power (Junction-to-Ambient)



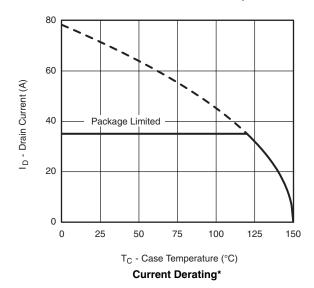
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

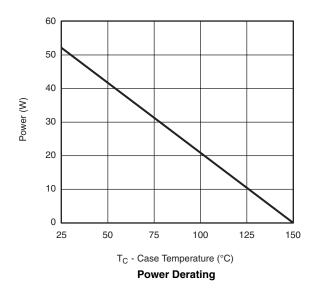
Safe Operating Area, Junction-to-Ambient





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

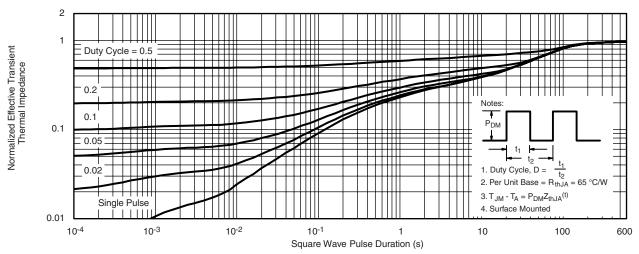




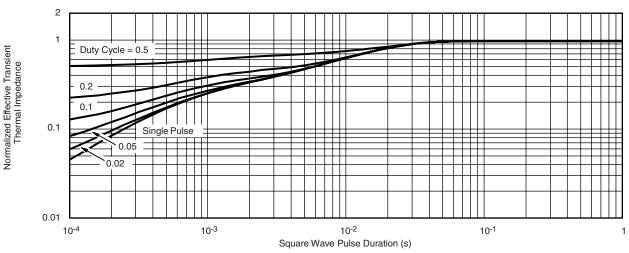
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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